

Notice of References Cited

Application/Control No.

09/454,515

Applicant(s)/Patent Under

Reexamination

LONNROTH ET AL.

Examiner

Chau Nguyen

Art Unit

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U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| | A | US-6,334,126 | 12-2001 | Nagatomo et al. | 707/4 |
| | B | US-6,397,259 | 05-2002 | Lincke et al. | 709/236 |
| | C | US-6,012,098 | 01-2000 | Bayeh et al. | 709/246 |
| | D | US-6,125,391 | 09-2000 | Meltzer et al. | 709/223 |
| | E | US-6,263,332 | 07-2001 | Nasr et al. | 707/5 |
| | F | US-6,480,860 | 11-2002 | Monday, Paul Brian | 707/102 |
| | G | US-6,477,549 | 11-2002 | Hishida et al. | 715/513 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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